

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner Mathieu D. Vargot	Art Unit 1732	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0003605	01-2002	Rogers et al.	351/160.00R
*	B	US-2002/0024158	02-2002	Nishigaki, Yoshiki	264/1.1
*	C	US-2002/0145861	10-2002	Nishigaki, Yoshiki	362/31
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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